



Search Notes 	Application/Control No. 10529331	Applicant(s)/Patent Under Reexamination KRAUSE ET AL.
	Examiner Wendler, Eric	Art Unit 2824


Notes	Date	Examiner
see attached EAST search history	9/20/2006	EJW
consulted with examiner Son Dinh on class 365	9/20/2006	EJW

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<i>Interference Searched</i> 	Application/Control No. 10529331	Applicant(s)/Patent Under Reexamination KRAUSE ET AL.
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Class	SubClass	Date	Examiner
365	63	9/20/2006	EJW
326	40	9/20/2006	EJW
326	41	9/20/2006	EJW
714	727	9/20/2006	EJW

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<p style="text-align: center;">Searched</p> 	<p>Application/Control No.</p> <p>10529331</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>KRAUSE ET AL.</p>
	<p>Examiner</p> <p>Wendler, Eric</p>	<p>Art Unit</p> <p>2824</p>

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